| Ref # | Hits | Search Query | DBs | Default Operator | Plurals | Time Stamp |
|----------|------|---|---|---------------------|---------|------------------|
| L1 | 5063 | ((hand adj writ\$3) or handwrit\$3)near3 recognit\$3 | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/12/11 16:09 |
| L2 | 622 | 1 and registrat\$3 | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/12/11 16:10 |
| L3 | 98 | 2 and segment and coordinat\$3 and angle and direct\$3 | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/12/11 16:11 |
| L4 | 98 | 3 and (compar\$5 or match\$3 or similar or similarity) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/12/11 16:13 |
| L5 | 86 | 4 and (sum or average or mean) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/12/11 16:13 |
| L6 | 80 | 5 and (region or area) and extract\$3 | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/12/11 16:14 |
| L7 | 26 | 6 and @ad<"20010129" | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2004/12/11 16:14 |

IEEE HOME | SEARCH IEEE | SHOP | WEB ACCOUNT | CONTACT IEEE



| Membership Public | ations/Services Standards Conferences Careers/Jobs | |
|--|--|---|
| IEEE) | Welcome United States Patent and Tradem | nark Office |
| Help FAQ Terms IEE | E Peer Review Quick Links | » Adva |
| Welcome to IEEE Xplore® - Home - What Can I Access? | Try our New Full-text Search Prototype GO 1) Enter a single keyword, phrase, or Boolean expression. | Help Search Options: |
| O- Log-out | Example: acoustic imaging (means the phrase acoustic imaging | Select publication types: |
| Tables of Contents | plus any stem variations) 2) Limit your search by using search operators and field codes, | ☑ IEEE Journals |
| | if desired. | ☑ IEE Journals |
| O- Journals & Magazines | Example: optical <and> (fiber <or> fibre) <in> ti</in></or></and> | ☑ IEEE Conference proceedings |
| O- Conference | 3) Limit the results by selecting Search Options.4) Click Search. See Search Examples | ☑ IEE Conference proceedings |
| Proceedings | | ✓ IEEE Standards |
| Search O- By Author | ((hand <near 5="">writing)or handwriting)and recognition and registration</near> | Select years to search: From year: All to Present |
| O- Basic O- Advanced O- CrossRef | Start Search Clear | Organize search results by: Sort by: Relevance In: Descending order |
| Member Services | Note: This function returns plural and suffixed forms of the | |
| O- Join IEEE | keyword(s). | List 15 Results per page |
| O- Establish IEEE Web Account | Search operators: <and> <or> <not> <in> More</in></not></or></and> | |
| O- Access the IEEE Member Digital Library | Field codes: au (author), ti (title), ab (abstract), jn (publication name), de (index term) <u>More</u> | |
| (ECE Enterprise | | |
| O- Access the | | |
| IEEE Enterprise File Cabinet | | |

Home | Log-out | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search | Join IEEE | Web Account |
New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No Robots Please | Release Notes | IEEE Online
Publications | Help | FAQ | Terms | Back to Top

Copyright © 2004 IEEE - All rights reserved

IEEE HOME | SEARCH IEEE | SHOP | WEB ACCOUNT | CONTACT IEEE



| Membership Publica | ations/Services Standards Conferences Careers/Jobs | | | | | |
|---|---|--|--|--|--|--|
| IEEE) | Welcome United States Patent and Trademark Office | | | | | |
| Help FAQ Terms IEE | E Peer Review Quick Links Se | | | | | |
| Welcome to IEEE Xplore* | | | | | | |
| O- Home O- What Can I Access? O- Log-out | Your search matched 5 of 1099723 documents. A maximum of 500 results are displayed, 15 to a page, sorted by Relevance Descending order. | | | | | |
| Tables of Contents - Journals & Magazines | Refine This Search: You may refine your search by editing the current search expression or enterinew one in the text box. ((hand <near 5="">writing)or handwriting)and recognition a Check to search within this result set</near> | | | | | |
| Conference Proceedings | | | | | | |
| Search | Results Key: JNL = Journal or Magazine CNF = Conference STD = Standard | | | | | |
| O- By Author O- Basic O- Advanced O- CrossRef Member Services | 1 Pen-based visitor registration system (PENGUIN) Matic, N.; Henderson, D.; Le Cun, Y.; Bengio, Y.; Signals, Systems and Computers, 1994. 1994 Conference Record of the Twer Eighth Asilomar Conference on , Volume: 1 , 31 Oct2 Nov. 1994 Pages: 298 - 302 vol.1 | | | | | |
| O- Join IEEE | [Abstract] [PDF Full-Text (444 KB)] IEEE CNF | | | | | |
| C Establish IEEE Web Account C Access the IEEE Member Digital Library | 2 Logo and word matching using a general approach to signal registra Suda, P.; Bridoux, C.; Kammerer, B.; Maderlechner, G.; Document Analysis and Recognition, 1997., Proceedings of the Fourth International Conference on , Volume: 1 , 18-20 Aug. 1997 Pages:61 - 65 vol.1 | | | | | |
| O- Access the IEEE Enterprise | [Abstract] [PDF Full-Text (404 KB)] IEEE CNF | | | | | |
| File Cabinet | The handwritten signature as a biometric identifier: psychophysical model and system design Plamondon, R.; Security and Detection, 1995., European Convention on , 16-18 May 1995 Pages: 23 - 27 | | | | | |
| | [Abstract] [PDF Full-Text (568 KB)] IEE CNF | | | | | |
| | 4 Intelligent system for reading handwriting on forms Garris, M.D.; System Sciences, 1998., Proceedings of the Thirty-First Hawaii International | | | | | |

http://ipaprenlamp.ipap.amg/eagrah/eagrahragetilt.ica2a.paprenlamg/=0/200/200 and 20/2 Chan 20/2 TEO/ 10/51/0/

Conference on , Volume: 3 , 6-9 Jan. 1998 Pages: 233 - 242 vol. 3 [Abstract] [PDF Full-Text (268 KB)] IEEE CNF

5 Design of an automated data entry system for hand-filled forms

Lin Woan Ning; Yap Keem Siah; Khalid, M.; Yusof, M.; TENCON 2000. Proceedings, Volume: 1, 24-27 Sept. 2000

Pages:162 - 166 vol.1

[Abstract] [PDF Full-Text (596 KB)] **IEEE CNF**

Home | Log-out | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search | Join IEEE | Web Account |
New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No Robots Please | Release Notes | IEEE Online
Publications | Help. | FAQ | Terms | Back to Top

Copyright © 2004 IEEE - All rights reserved